

N-Channel Enhancement Mode MOSFET

Feature

- 30V/11A
 - $R_{DS(ON)}=7.3m\Omega(typ.)@V_{GS}=10V$
 - $R_{DS(ON)}=11 \text{ m}\Omega(typ.)@V_{GS}=4.5V$
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

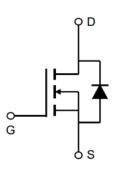
Pin Description



SOP8L

Applications

- Power Management for DC/DC
- Switching Application
- Battery Protection



N-Channel MOSFET

Ordering and Marking Information



Package Code S: SOP8L

Date Code XYWXXXXXX

Note:HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nationfinish; which are fully compliant with RoHS.HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature.HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Ra	tings (Tc=25°C Unless Otherwise Noted)			
VDSS	Drain-Source Voltage		30	V
Vgss	Gate-Source Voltage		±20	V
TJ	Junction Temperature Range		-55 to 175	°C
Tstg	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode)	11	А	
Mounted on	Large Heat Sink			
Ірм	Pulsed Drain Current *	Tc=25°C	44	А
	Outing a Paris Out of	Tc=25°C	11	А
lo	Continuous Drain Current	Tc=100°C	7	А
	M : 5 5: : ::	Tc=25°C	2.5	W
PD	P _D Maximum Power Dissipation Tc=10		1.0	W
R _{euc}	Thermal Resistance, Junction-to-Case	60	°C/W	
R _{eJA}	Thermal Resistance, Junction-to-Ambient		80	°C/W
Eas	SinglePulsed-Avalanche Energy **	L=0.1mH	32	mJ

Note: *

- * Repetitive rating; pulse width limited by max.junction temperature.
- ** Limited by TJmax , starting TJ=25°C, L = 0.3mH, Rg= 25Ω , Vgs =10V.

Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions		HYG082N03LR1			Unit
Symbol	Farameter Test Conditions		Min	Тур.	Max	Offic	
Static Characteristics							
BVDSS	Drain-Source Breakdown Voltage	$V_{GS}=0V,I_{DS}=2$	250μΑ	30	-		V
Ipss	Drain to Source Leakage Current	VDS=30V,VGS	S=0V	ı	-	1	μΑ
IDSS	Drain-to-Source LeakageCurrent		TJ=125°C	ı	-	50	μA
V _{GS(th)}	Gate Threshold Voltage	VDS=VGS, IDS=250µA		1	1.8	3	V
Igss	Gate-Source Leakage Current	Vgs=±20V,Vps=0V		ı	-	±100	nA
Rds(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =10A			7.3	10.5	mΩ
KDS(ON)	Dialii-Source Oil-State Resistance	V _{GS} =4.5V,I _{DS} =5A			11	14.5	11122
Diode Char	Diode Characteristics						
Vsp*	Diode Forward Voltage	IsD=10A,Vgs=0V		-	0.8	1.2	V
trr	Reverse Recovery Time		/dt_1004/us	-	8	-	ns
Qrr	Reverse Recovery Charge	Isp=10A,dlsp	/ul=100A/µS	-	2.4	-	nC

HYG082N03LR1S



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cumbal	Dorometer	Took Conditions	HY	HYG082N03LR1			
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit	
Dynamic (
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V, Frequency=1.0MHz	-	1	-	Ω	
Ciss	Input Capacitance	Vgs=0V,	-	787	1		
Coss	Output Capacitance	V _{DS} =25V,	-	108	-	pF	
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	65	-		
td(ON)	Turn-on Delay Time		-	8	-		
Tr	Turn-on Rise Time	$V_{DD}=15V,R_{G}=4\Omega,$	-	30.8	-	no	
td(OFF)	Turn-off Delay Time	los=10A,Vgs=10V	-	19.5	-	ns	
Tf	Turn-off Fall Time		-	18.8	-		
Gate Char	Gate Charge Characteristics						
Q_g	Total Gate Charge	V 24V V 40V	-	14.8	-		
Qgs	Gate-Source Charge	$V_{DS} = 24V, V_{GS} = 10V,$ $I_{D} = 10A$	-	2.1	-	nC	
Qgd	Gate-Drain Charge	ID-10A	-	3.4	-		

Note: *Pulse test, pulse width ≤ 300us, duty cycle ≤ 2%



Typical Operating Characteristics

Figure 1: Power Dissipation

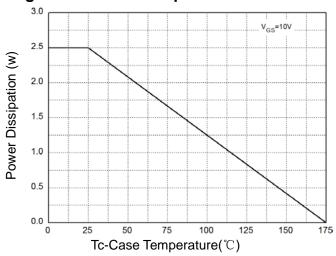


Figure 2: Drain Current

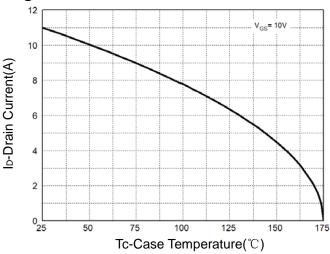


Figure 3: Safe Operation Area

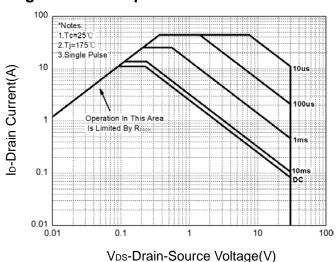


Figure 4: Thermal Transient Impedance

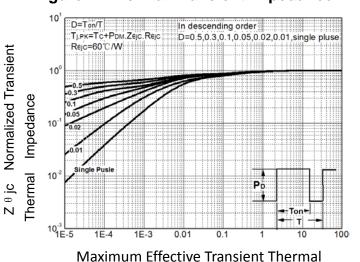
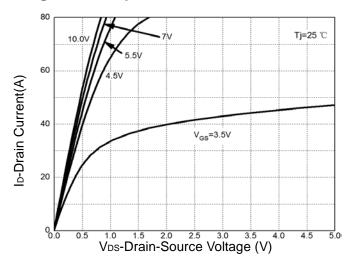
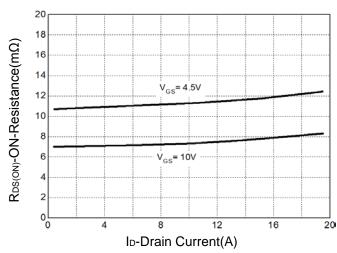


Figure 5: Output Characteristics



Impedance, Junction-to-Case

Figure 6: Drain-Source On Resistance





Typical Operating Characteristics

Figure 7: On-Resistance vs. Temperature

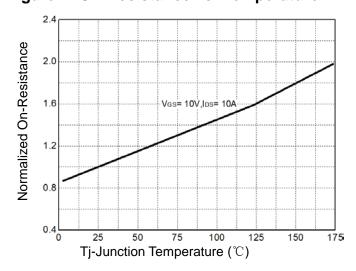


Figure 8: Source-Drain Diode Forward

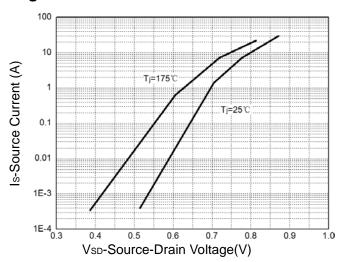


Figure 9: Capacitance Characteristics

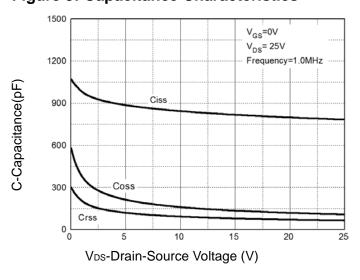
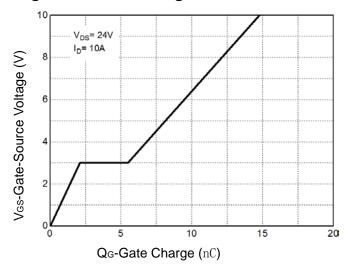
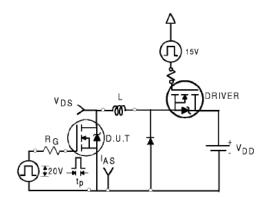


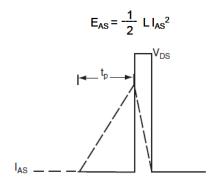
Figure 10: Gate Charge Characteristics



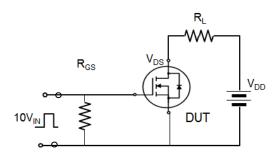


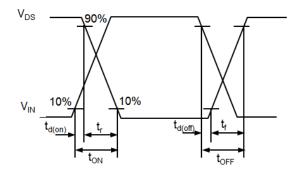
Avalanche Test Circuit



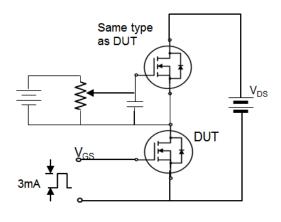


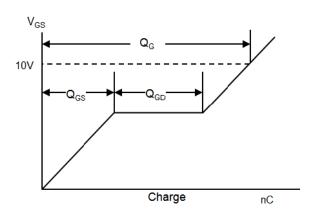
Switching Time Test Circuit





Gate Charge Test Circuit





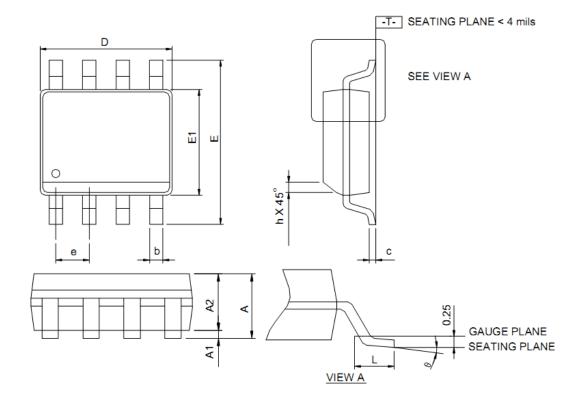


Device Per Unit

Package Type	Unit	Quantity
SOP8L	Reel	2500

Package Information

SOP8L



ş		SO	P8L	
SP MBO	MILLIM	ETERS	INC	HES
6	MIN.	MAX.	MIN.	MAX.
Α	-	1.75	-	0.069
A1	0.10	0.25	0.004	0.010
A2	1.25	-	0.049	-
b	0.31	0.51	0.012	0.020
С	0.17	0.25	0.007	0.010
D	4.80	5.00	0.189	0.197
Е	5.80	6.20	0.228	0.244
E1	3.80	4.00	0.150	0.157
е	1.27 BSC		0.05	0 BSC
h	0.25	0.50	0.010	0.020
L	0.40	1.27	0.016	0.050
θ	0°	8°	0°	8°

Note: 1. Follow JEDEC MS-012 AA.

- Dimension D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 6 mil per side.
- Dimension E" does not include inter-lead flash or protrusions. Inter-lead flash and protrusions shall not exceed 10 mil per side.

1.27 2.2 † 5.74 2.87 1.27 5.74

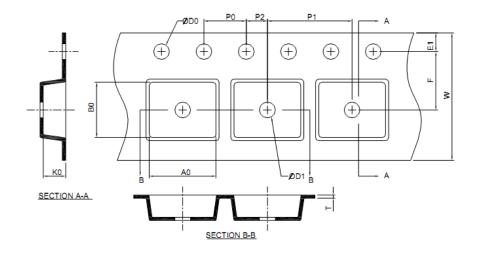
UNIT: mm

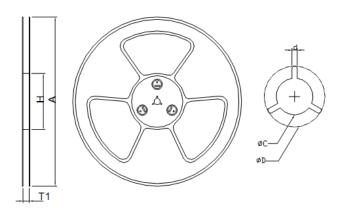
0.635

RECOMMENDED LAND PATTERN



Carrier Tape & Reel Dimensions

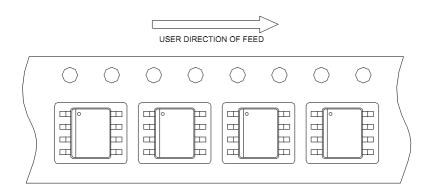




Application	Α	Н	T1	С	d	D	W	E1	F
	330.0 2.00	50 MIN.	12.4+2.00 -0.00		1.5 MIN.	20.2 MIN.	12.0 0.30	1.75 0.10	5.5 0.05
SOP8L	P0	P1	P2	D0	D1	T	A0	B0	K0
								5.20 0.20	

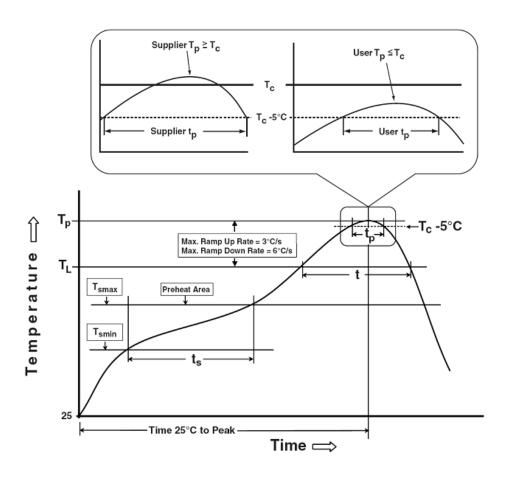
(mm)

Taping Direction Information





Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak	100 °C	150 °C
Temperature min (T _{smin})	150 °C	200 °C
Temperature max (T _{smax})	60-120 seconds	60-120 seconds
Time (Tsmin to Tsmax) (t _s)	00-120 3econds	00-120 seconds
Average ramp-up rate	2 °C/accord may	2°C/cocond may
(T _{smax} to T _P)	3 °C/second max.	3°C/second max.
Liquidous temperature (T _L)	183 °C	217 °C
Time at liquidous (t _L)	60-150 seconds	60-150 seconds
Peak package body Temperature	See Classification Temp in table 1	SacClassification Tomain table 2
(T _p)*	See Classification Temp in table 1	SeeClassification Tempin table 2
Time (t _P)** within 5°C of the specified	20** seconds	30** seconds
classification temperature (T _c)	20 seconds	30 seconds
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
·		

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

HYG082N03LR1S



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm ³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168 Hrs/500 Hrs/1000Hrs, Bias @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

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